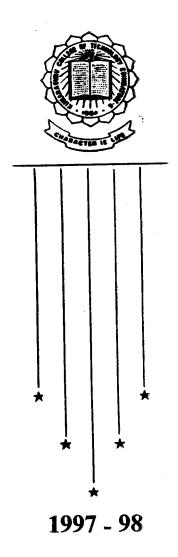
# Calibration of DC Ammeter Using Feedback Control

# PROJECT REPORT





Submitted by T. BINU B. BHARATH S.M. RAJARAM S. SRITHAR

Guided by

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Sponsored by PRICOL, Coimbatore

IN PARTIAL FULFILMENT OF THE REQUIREMENTS

FOR THE AWARD OF THE DEGREE OF

BACHELOR OF ENGINEERING IN

ELECTRICAL & ELECTRONICS ENGINEERING

OF THE BHARATHIAR UNIVERSITY

DEPARTMENT OF ELECTRICAL & ELECTRONICS ENGINEERING

# Kumaraguru College of Technology

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# CERTIFICATE

This is to certify that the Project entitled

# CALIBRATION OF DC AMMETER USING FEEDBACK CONTROL

has been submitted by

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In partial fulfilment of the requirements for the award of degree of Bachelor of Engineering in the Electrical & Electronics Engineering branch of the Bharathiar University, Coimbatore - 641 046 during the academic year 1997-98.

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Certified that the candidate with U	Iniversity Register No			
was examined in project work Viv	a-Voce Examination held on			
Internal Examiner	External Examiner			

#### PREMIER INSTRUMENTS & CONTROLS LIMITED



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HRD/PROJECT/98

31st March 1998

#### TO WHOMSDEVER IT MAY CONCERN

This is to certify that the following Final BE (EEE) students of Kumaraguru College of Technology, Colmostore have carried out a project work in our organisation is Plant Maintenance Department from 1st January 1978 to 51st March 1998.

- 1 Mr T Binu
- 2. Mr B Bharath
- 3. Mr SM Rajaram
- 4. Mr S Srithar

The title of the project was "CALIBRATION OF DC AMMETER USING FEEDBACK CONTROL".

During this period, their attendance and conduct were found to be good.

We wish them the very best for a bright future.

LT COL S PURUSHOTHAMAN

DEPUTY GENERAL MANAGER - HUMAN RESOURCES



# **ACKNOWLEDGEMENT**

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# SYNOPSIS

The feedback controlled D.C. ammeter calibrator is designed specifically for calibrating dashboard indicator, indicating the charging and discharging of D.C. batteries which is widely used in two wheelers as well as four wheelers.

As the industry have frequent fluctuations at the input supply, it is very necessary to suppress the fluctuations while calibrating. The newly designed calibrator is standardised by including a feedback circuit which compensates any fluctuation in the input supply such that no disturbance is felt when the meter under test is calibrated with the standard meter.

The calibrator provides a variable range of testing current (0A to 50A), in both positive and negative directions.

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#### CHAPTER - 1

#### INTRODUCTION

Calibration of a meter is a process by which the standard meter is compared with manufactured meter for detecting the accuracy of the newly manufactured meter. While calibrating, if any deviation is found in the newly manufactured meter with that of standard meter, the new meter is adjusted to match the standard one.

The Battery charge indicator meter, which shows both the charging and discharging of the current, has to be tested for both positive and negative directions of current. This project provides relay circuits to change the direction of current so that both the positive as well as negative current in the newly manufactured meter is calibrated with  $\pm 1\%$  accuracy.

This project takes care about the ISO standard requirements of the calibrating equipment with regulation of 1% variation when the input variation is about  $\pm$  10%.

The principle used to regulate current is the standard feedback control. The error developed due to the change in the input signal is compared with the reference and the error is amplified through a differential amplifier which is fed back to the oscillatory circuit which varies its pulse width to maintain a regulated output.

The various circuits which forms the calibrator are as follows:

A relay circuit to get deflection in both the directions.

A control circuit to stabilise the input given to the triac.

A synchronising circuit to synchronise the a.c. supply and control circuit output.

A separate power supply for relay and power devices.

#### 1.1. BLOCK DIAGRAM

The major circuits involved in the D.C. ammeter calibrator are

#### 1.1.1. Voltage control by triac:

The circuit consists of bi-directional device triac which is connected with triggering circuit for gate pulses. Any variation in the input supply is sensed by control circuit and given to triac gate input, hence better regulation is obtained.

#### 1.1.2. Rectifier circuit:

The stepped down input supply is rectified into a smooth dc. by the rectifier circuit. The standard D.C. being given to the test meter panel.

#### 1.1.3. Control Circuit:

The control circuit involves pre-amplifier, buffer amplifies and differential amplifies which senses any change in the input supply. This circuit is used to fix the range of current in the calibrator.

### 1.1.4. Triggering circuit:

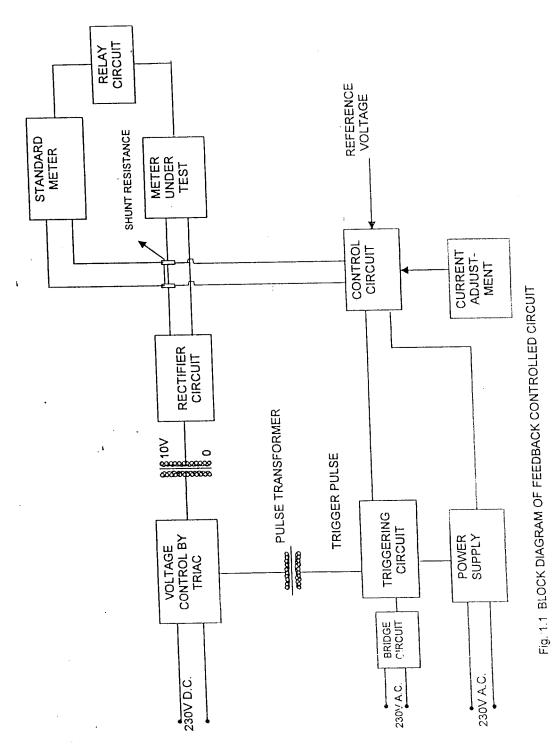
The triggering circuit used here is UJT relaxation oscillator circuit, which supplies the gate pulses to the triac.

#### 1.1.5. Meter Panel:

The meter panel consists of standard meter and the meter to be tested.

#### 1.1.6. Relay circuit:

Relay circuit is used to change the direction of current in both negative and positive.



#### CHAPTER - 2

#### CIRCUIT DESIGN

#### 2.1. POWER CIRCUIT

#### 2.1.1. INTRODUCTION

The power circuit consists of the input power supply 230 V, 50 Hz with triac which regulates the input given to the meter panel. The change in the triggering pulse angle, provides the regulation of the circuit.

The triac is used for the stabilization of the input. The triac controlled circuit consists of

- (i) Power circuit for Triac
- (ii) Driver or trigger circuit
- (iii) Controller.

#### 2.1.2. Power Circuit for Triac:

The power circuit consists of thyristors and diodes. The diode is rated at 60A and 5V, the 230V being stepped down to 5V by a centre tap transformer. The triac is connected in series, the gate pulse being

provided through a pulse transformer. The thyristors and the triac are being mounted on a heat sink to dissipate the heat being generated.

# 2.1.3. Driver or Trigger Circuit:

The trigger circuit consists of the UJT relaxation oscillator which produces train of pulses and this being given to the gate of the triac through a pulse transformer. The pulse transformer acts as a isolation between the power circuit and control circuit. The trigger circuit is in between the controller and the power device, triac.

#### 2.1.4. Controller:

The controller circuit consists of the operational amplifiers which acts as a feedback to the UJT input such that the input to the meter panel is regulated.

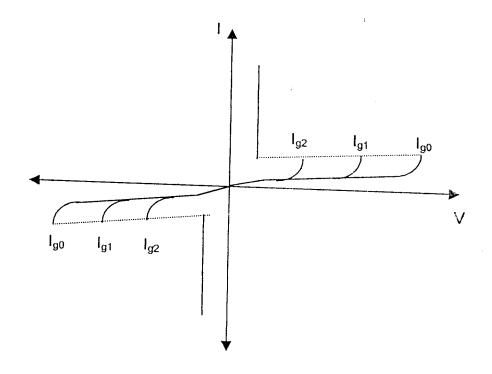


Fig. 2.1. V – I CHARACTERISTICS OF TRIAC

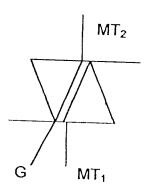


Fig. 2.2. CIRCUIT SYMBOL OF TRIAC

# 2.1.5. Triggering:

The triggering of triac can be done in three ways.

- (i) Pulse triggering
- (ii) Single pulse triggering
- (iii) D.C. triggering

The method being employed here is the pulse triggering. The UJT oscillator produces a train of pulses to trigger the triac at various instances which inturn is governed by control circuit.

#### 2.1.6. Relays:

Relay 1 in the circuit diagram is used to switch ON or OFF the calibrator, the relay1 is also connected to the range setting circuit such that it cuts off the supply whenever the current exceeds the setting current.

Relay 2 and Relay 3 are connected so that the current direction can be changed from positive to negative range or vise versa. These relays are connected to the standard meter as well as meter under test.

Push buttons are provided to energise these relays such that the direction of current can be changed whenever needed while calibrating.

#### 2.1.7. Filter:

Inductive filter is used to smoothen the pulsating D.C. produced at the output of the step down transformer, the choke being connected to the centre tap. Separate connection to a step down transformer is made to connect the regulator circuits, which needs 16V as input.

The standard meter of the panel has been designed to have 1 Amp of current for 1mV. A shunt resistance is provided such that same current is allowed to follow both in standard meter as well as meter to be tested.

### 2.2. CONTROL CIRCUIT

#### 2.2.1. INTRODUCTION

The control circuit uses operational amplifier IC741 to detect any change in the input supply and magnify the error such that it can feed it to UJT oscillatory circuit which inturn regulates the output at the meter panel. The control circuit is also used to set the range of current, both positive and in negative directions of current.

The various operational amplifiers used are as follows.

### 2.2.2. Buffer Amplifier:

Buffer amplifier or voltage follower has unity gain and hence the input voltage is equal to the output voltage. The buffer amplifier has high input impedance and zero output impedance. The output voltage has same magnitude and phase as that of input voltage. Here maximum of 12V can be set. The buffer amplifier acts as a reference voltage to the error or differential amplifier.

# 2.2.3. Pre Amplifier:

The input of the preamplifier is taken from the transformer output of the power circuit. The input to preamplifier may be in few milli-volts, hence it should be amplified using this preamplifiers. As the power circuit is in high current area, there is chance of getting sparks in the meters and hence there will be current drop accordingly. In order to avoid these drawbacks the preamplifier is used.

# 2.2.4. Error Amplifier:

The error amplifier is the differential amplifier. This amplifier amplifies the difference between two signals. The two inputs given to the error amplifier are

- The reference voltage taken from the output of the buffer amplifier.
- ii) The output taken from the preamplifier

The difference between these two signals taken from the buffer amplifies and pre amplifier is amplified by the difference or error amplifier. This signal is given to the oscillatory circuit.

### 2.2.5. UJT Relaxation Oscillator.

UJT exhibits negative resistance characteristics and hence it can be used as a relaxation oscillator. Also the external resistance connected to the UJT are small in comparison with the internal resistance of the UJT base, hence the circuit using uni-junction transistor is fairly simple and less expensive.

The output of the differential amplifier is amplified through a transistor and given to base 1 of the uni-junction transistor. Another input for the base 2 of the UJT is from the synchronization circuit.

The diodes are connected to UJT such that it is reverse biased, hence it allows only the negative voltage from the error amplifier into the UJT oscillatory circuit.

The oscillatory circuit thus created causes pulses at the base. This output is given to a darlington circuit. The darlington circuit gives high impedance and high gain. It matches the impedance of the AC input given to base 1 and the signal given to the gate of the triac. It also acts as an amplification of the oscillatory output.

#### 2.2.6. Isolator:

An isolator is used to isolate the power circuit of high current and control circuit of low current. The pulse transformer is used as an isolator here. The turn ratio being 1:1, the pulse from the darlington pair is given to the pulse transformer.

In this circuit, the capacitor is charged through the resistance until the capacitor voltage reaches the peak-point emitter voltage of the UJT. At this time, the UJT turns on. The capacitor is discharged through the primary of the pulse transformer. A pulse is produced at the primary, as well as at the secondary of the pulse transformer. This is the gate triggering pulse. When the voltage across the capacitor sinks, the UJT

turns off and the capacitor charges again and the whole process repeats itself.

The period of oscillation T is fairly independent of temperature. The time period is given as

$$T = \frac{1}{f} = RC \ln \frac{1}{1 - \eta}$$
 (2.1)

Where  $\eta$  is the intrinsic stand off ratio of UJT

The value of the capacitor should be such as to store sufficient charge to trigger the SCR. The charging resistance must be sufficiently small to admit the required peak point current of the UJT from the supply voltage.

If the emitter diode drop is neglected

$$R < \frac{V_1 - V_P}{I_P}$$
 (2.2.)

Where  $V_1$  is the UJT supply voltage

 $V_p$  is the peak point emitter voltage of the UJT

 $I_P$  is the peak point emitter current of the  $\dot{\text{UJT}}$ 

Again, resistance must be sufficiently large for the voltage at the intersection point of the load line and UJT characteristic curve to be greater than the valley voltage of the UJT

$$R > \frac{V_{i} - Vv}{Iv} \tag{2.3}$$

 $V_{v}$  is the valley voltage for a particular inter-base voltage  $V_{BB}$  of the UJT.

 $I_V$  is the valley current corresponding to  $V_V$ .

The above two equations specify the maximum and minimum limit of the value of resistance R for the condition of relaxation oscillator.

### 2.3. SYNCHRONISING CIRCUIT

The synchronising circuit synchronises the triggering pulses with the A.C. input to the UJT relaxation oscillator. A bridge circuit from the main supply with zener diode connected across it forms the synchronising circuit, the zener diode provides stabilisation of the supply voltage and helps in the production of pulses of equal magnitude. The UJT triggers when its emitter voltage exceeds the peak-point voltage of the emitter which is a function of the supply voltage. In the relaxation oscillator circuit, the emitter voltage is the voltage across the capacitor, C and is saw-toothed.

The UJT will trigger when

Where

$$V_e > V_P \approx \eta V_1 \tag{2.4.}$$

V<sub>c</sub> is the voltage across the capacitor

V<sub>p</sub> is the peak point voltage of UJT

 $\eta$  is the intrinsic stand off ratio of UJT

 $V_1$  is the supply voltage.

The mode of UJT control makes the supply line synchronisation a simple matter in a.c. circuits. The voltage  $V_1$  is derived from the unfiltered output of a zener-diode-clipped full wave rectified a.c supply line voltage.

The voltage V<sub>1</sub> will clip when

$$e < V_z$$
 (2.5)

Where,

e is the instantaneous supply voltage

 $V_z$  is the voltage across the zener diode,

### 2.4. RELAY DRIVING CIRCUIT

The relays are used to change the direction of current in both positive and negative direction. Push buttons PB1 and PB2 (refer fig.) are used to drive the relays.

The push buttons PB1 is used to get the deflection of current in negative direction and PB2 for positive direction of current.

The relays are energised by switching on the transistor by biasing it. When PB2 is pressed, the 12V supply is given to the base of the transistor CL100, now the transistor is biased. Now the relays 2 and 3 is energised as 30V is applied across it or the relay is said to be switched on.

The 30V supply is used to bias the other two transistors in the circuit. As the transistor gets biased it inturn energies the relay 1. Hence the deflection will be in positive direction.

When PB1 is pressed, the transistor is not biased and remains off since no supply is given to the base of the transistor the relays 2 and 3

remain non-energised. But it energies the relay 1, hence the direction of current is in the negative direction.

The relay energising coil is provided with a diode which protects the transistor when the supply is switched off suddenly.

#### 2.5. POWER SUPPLY

Step-down transformers are used to get low voltages. A 16V supply is tapped from the secondary of the step down transformers and given to the regulators 7812 and 7912 which is used to produce a constant voltage of +12V and -12V. The constant +12V is used in the control circuit for reference voltage.

The regulatory circuit for 12V regulatory circuit is connected with capacitors to improve the performance and to eliminate transient spikes which may cause damage to the regulator circuit.

Again for energising the relay circuit, 30V supply is required, for this a 22V secondary output transformer is connected to the supply and is given to the bridge rectifier circuit which rectifies the input.

$$V_{dc} = 1.414 \times V_{AC}$$
 (2.7)

Which is approximately equal to 30V.

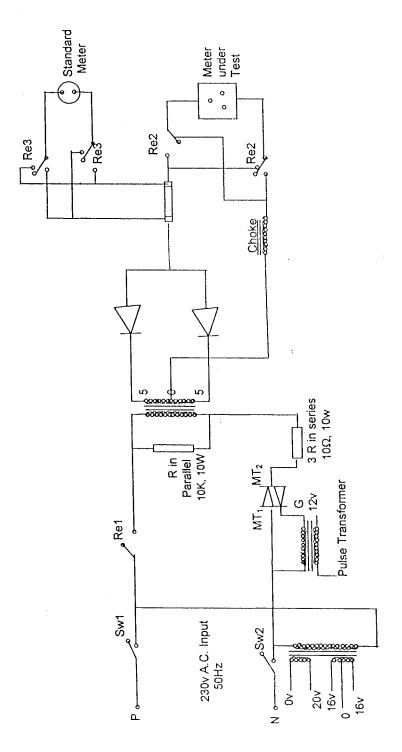
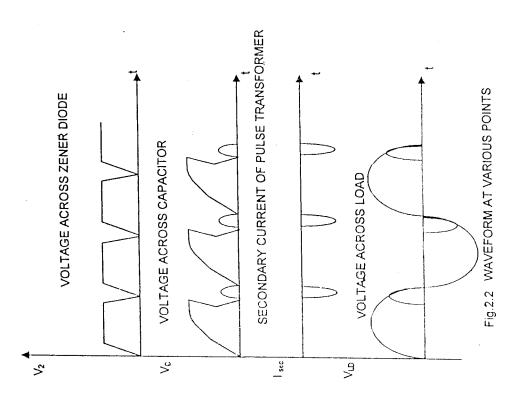


Fig.2.1 POWER CIRCUIT



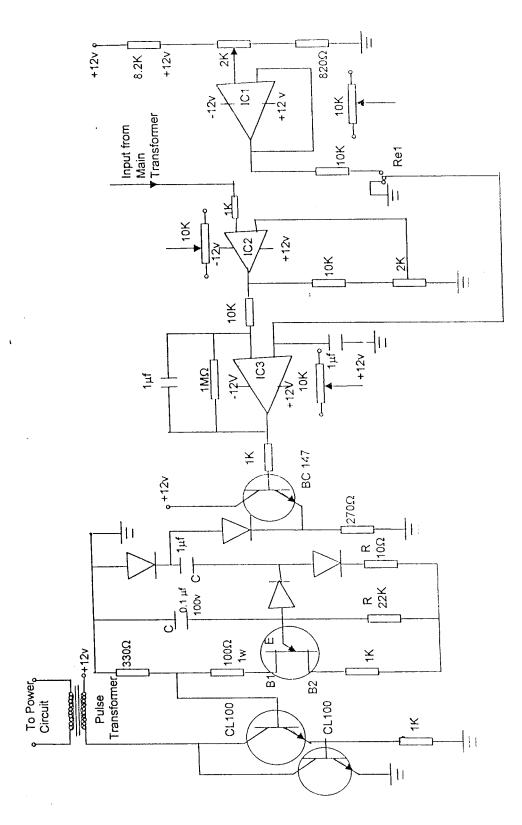
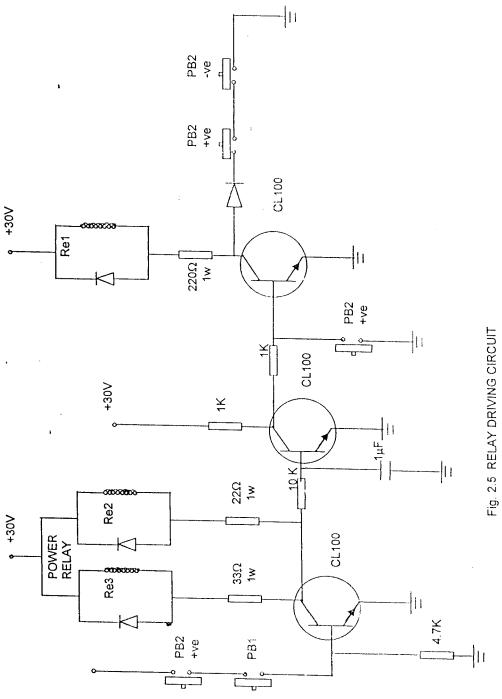


Fig 2.4 SYNCHRONISING CIRCUIT



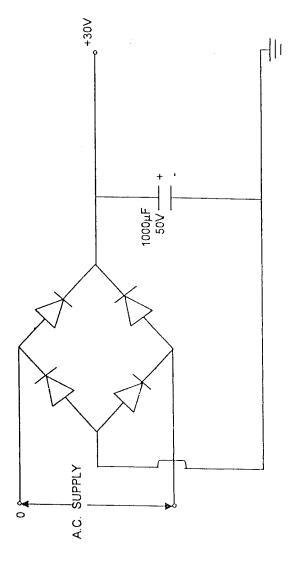


Fig 2.6 30V POWER SUPPLY

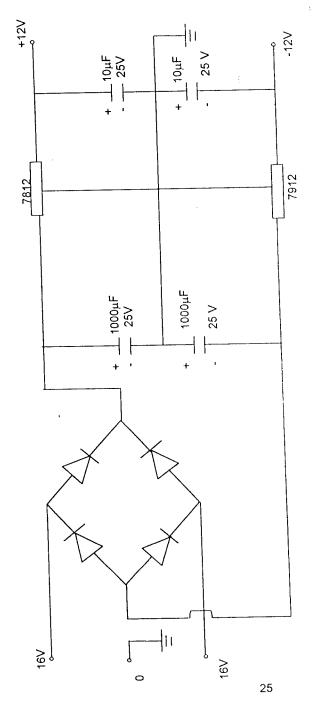


Fig 2.7 ± 12V POWER SUPPLY

# CHAPTER - 3

# **FABRICATION AND TESTING**

#### 3.1. FRONT PANEL

The circuit shown in fig. 2.1.0 is fabricated. The power circuit, synchronising circuit and the control circuit are fabricated on a PCB. The transformer for various lower voltage requirements amounted on the calibrator box base. A fan is mounted at the side of the box to remove the heat from the arrangement. The box is about 24 inches in length, 20 inches in breadth and 20 inches in height. The front panel shown in the fig. 2.1.1.

The front panel of the D.C. ammeter calibrator consists of the following

# 3.1.1. ON – OFF Switch:

The supply is given to the calibrator through this switch, which switches on or off the calibrator.

# 3.1.2. Indication Lamp:

To indicate the availability of power in the calibrator circuit.

### 3.1.3. Digital panel meter:

The digital panel meter is the standard D.C. ammeter used to calibrate the meter under test. This is used as the reference meter.

# 3.1.4. Variable range switch:

This switch is provided to vary the current range from 0 to 50 Amps.

#### 3.1.5. Push buttons:

Push buttons are provided to get the deflection of current in both the directions, the push buttons being connected to the relay circuit.

### 3.1.6. Three hold pin:

Three pin setup for inserting the meter to be tested.

#### 3.1.7. Potentiometers:

Potentiometers are provided to set the range of current as well as to change the value of current.

- Insert the meter to be calibrated to the terminals provided on the front panel.
- 4. Operate the push button "+". The current in both the standard and the meter to be tested flows in positive direction. Now any error in the newly manufactured meter can be tested, using the calibrator and required adjustment can be made in the meter such that it reads same as the standard meter.
- 5. The meter is now tested for negative direction. The "-" push button is operated, the current will flow in negative direction. The meter to be tested can be compared with newly manufactured meter for negative deflection of current. The necessary adjustments is made on the meter with deflection error.
- 6. The variable range switch allows the operator to set a particular range within which the meter can be tested.

# 3.2. SPECIFICATIONS AND OPERATING INSTRUCTIONS

#### 3.2.1. SPECIFICATION:

Accuracy

: 1% of set value

Current range

: Variable from 0 to 50Amps

Line regulation

: 1% for mains voltage variation of  $\pm$  1%

Read out

moving coil D.C. Ammeter ± 1%

Power supply

230V  $\pm$  10% 50Hz A.C. single phase

350 Watts

#### 3.2.2. OPERATING INSTRUCTIONS

The operating instructions to be following while calibrating the meter to be tested are

- 1. The instrument is provided with three pin mains cord. Make sure that the line, neutral and ground are connected properly.
- Connect the instrument to the suitable three pin mains outlet switch the instrument "ON" by the "POWER ON" switch. If the line, neutral and ground are not connected properly the indication lamp will not glow.

# 3.3. TESTING AND RESULT

This model has been tested at Premier Instruments and Controls limited and worked upto the expectation.

Line Regulation : 1% for Mains voltage of ± 10%

Accuracy : 1% of set value.

The following results were obtained at the meter testing and calibrating department, when few newly manufactured meter were tested with this newly designed calibrator. The results are as follows

Meter under Test	POSITIVE				NEGATIVE			
	Set value				Set value			
	0	25	50	Error rectification	0	25	50	Error rectification
Meter 1	0.1	25.1 <sub>.</sub>	50.1	-0.1	0.1	24.9	49.9	+0.1
Meter 2	0.16	25.16	50.16	-0.16	0.16	24.84	49.84	+0.16
Meter 3	-0.12	24.88	49.88	+0.12	-0.12	25.12	50.12	-0.12

When the same meters were tested in the old rheostatic methods, following results were obtained.

Meter			SITIVE		NEGATIVE			
under	Set value		F		Set value			
Test	0	25	50	Error rectification	0	25	50	Error rectification
Meter1	0.21	25.21	50.21	-0.21	0.21	24.79	49.79	+0.21
Meter 2	0.23	25.23	50.23	-0.23	0.23	24.77	49.77	+0.23
Meter 3	-0.22	24.78	49.78	+0.22	-0.22	25.22	50.22	-0.22

When same meters were tested with another accurate method with ISI standard meter, the following results were obtained.

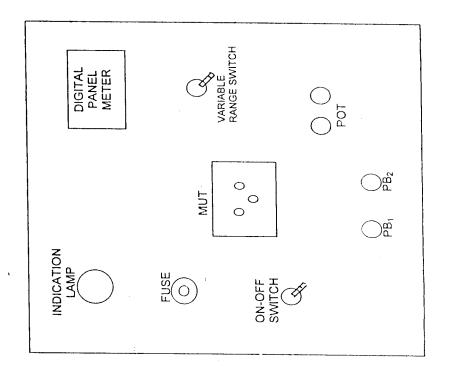
		PC	SITIVE		NEGATIVE				
Meter		Set valu	е	_		Set valu	<u></u>		
under Test	0	25	50	Error rectification	0	25	50	Error rectification	
Meter 1	0.1	25.1	50.1	-0.1	0.1	24.9	49.9	+0.1	
Meter 2	0.15	25.15	50.15	-0.15	0.15	24.85	49.85	+0.15	
Meter 3	-0.12	24.88	49.88	+0.12	-0.12	25.12	50.12	-0.12	

Comparison of Rheostatic method and newly designed calibrator is as follows.

Meter		Pos	sitive	Nega	ıtive
under	Set	Rheostatic	Newly	Rheostatic	Newly
Test	value	Method	designed calibrator	Method	designed calibrator
	0	-0.21	-0.1	0.21	0.1
1	25	-0.21	-0.1	0.21	0.1
_	50	-0.21	-0.1	0.21	0.1
	0	-0.23	-0.16	0.23	0.16
2	25	-0.23	-0.16	0.23	0.16
	50	-0.23	-0.16	0.23	0.16
	0	-0.22	-0.12	0.22	0.12
3	25	-0.22	-0.12	0.22	0.12
	50	-0.22	-0.12	0.22	0.12

# 3.4. COST ESTIMATION

Cost Rs. P.
2,000.00
1,400.00
2,000.00
70.00
45.00
1,100.00
300.00
1,200.00
925.00
400.00
900.00
860.00
11,200.0
-



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# 3

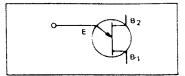
# N Unijunction Transistors ilicon PN Unijunction Transistors

. designed for use in pulse and timing circuits, sensing circuits and thyristor gger circuits. These devices feature:

Low Peak Point Current — 2  $\mu$ A (Max) Low Emitter Reverse Current — 200 nA (Max) Passivated Surface for Reliability and Uniformity

## 2N2646 2N2647

PN UJTs





MAXIMUM RATINGS (T<sub>A</sub> = 25°C unless otherwise noted.)

Rating	Symbol	Value	Unit
Power Dissipation, Note 1	PD	300	mW
RMS Emitter Current	lE(RMS)	50	mA
Peak Pulse Emitter Current, Note 2	įE ,	2	Amps
Emitter Reverse Voltage	V <sub>B2E</sub>	30	Volts
Interbase Voltage	V <sub>B2B1</sub>	35	Volts
Operating Junction Temperature Range	. Tj	-65 to +125	°C
Storage Temperature Range	T <sub>stg</sub>	-65 to +150	°C

'Indicates JEDEC Registered Data.

Notes: 1. Derate 3 mW/°C increase in ambient temperature. The total power dissipation (available power to Emitter and Base-Two) must be limited by the external circuitry.

2. Capacitor discharge — 10  $\mu F$  or less, 30 volts or less.

## \*ELECTRICAL CHARACTERISTICS (T<sub>A</sub> = 25°C unless otherwise noted.)

Characteristic		Symbol	Min	Two	1	T
Intrinsic Standoff Ratio (VB2B1 = 10 V), Note 1	2N2646 2N2647	η	0.56	Тур	0.75 0.82	Unit —
Interbase Resistance (VB2B1 = 3 V, IE = 0)		rBB	4.7	7	9.1	k ohms
Interbase Resistance Temperature Coefficient (VB2B1 = 3 V, I <sub>E</sub> = 0, T <sub>A</sub> = -55°C to +125°C	C)	<sup>α</sup> rВВ	0.1		0.9	%/°C
Emitter Saturation Voltage (VB2B1 = 10 V, I <sub>E</sub> = 50 mA), Note 2		V <sub>EB1(sat)</sub>	_	3.5		Volts
Modulated Interbase Current (VB2B1 = 10 V, IE = 50 mA)		lB2(mod)	_	15		mA
Emitter Reverse Current (VB2E = 30 V, IB1 = 0)	2N2646 2N2647	lEB2O		0.005 0.005	12 0.2	μА
Peak Point Emitter Current (VB2B1 = 25 V,)	2N2646 2N2647	lр		1	5 2	μΑ
Valley Point Current (VB2B1 = 20 V, RB2 = 100 ohms), Note 2	2N2646 2N2647	IV	4 8	6 10	18	mA
Base-One Peak Pulse Voltage (Note 3, Figure 3)	2N2646 2N2647	V <sub>OB1</sub>	3 6	5 7		Volts

<sup>\*</sup>Indicates JEDEC Registered Data.

Notes:

1. Intrinsic standoff ratio,

 $\eta$ , is defined by equation:

$$\eta = \frac{V_P - V_F}{V_{B2B1}}$$

Where Vp = Peak Point Emitter Voltage

VB2B1 = Interbase Voltage

V<sub>F</sub> = Emitter to Base-One Junction Diode Drop (~ 0.45 V @ 10 μA)

- 2. Use pulse techniques: PW  $\approx$  300  $\mu$ s, duty cycle  $\leq$  2% to avoid internal heating due to interbase modulation which may result in erroneous readings.
- Base-One Peak Pulse Voltage is measured in circuit of Figure 3. This
  specification is used to ensure minimum pulse amplitude for
  applications in SCR firing circuits and other types of pulse circuits.

### FIGURE 1

### UNIJUNCTION TRANSISTOR SYMBOL AND NOMENCLATURE

### FIGURE 2

### STATIC EMITTER CHARACTERISTIC **CURVES**

(Exaggerated to Show Details)

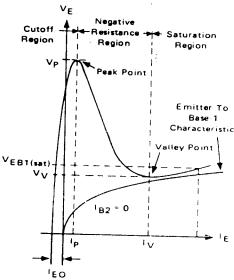
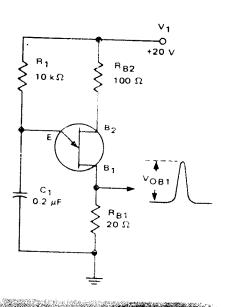
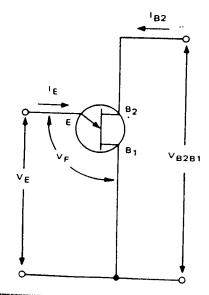


FIGURE 3 - VOB1 TEST CIRCUIT (Typical Relaxation Oscillator)





## MOTOROLA THYRISTOR DEVICE DATA

## **RECTIFIER NUMBERING SYSTEM**

**PART NUMBER KEY** XXXXXXXX XXXR = REVERSE PREFIX -10 ۷R L = LOW VF (TYPE DESIGNATOR) (X10 EXCEPT E = ENERGY SCHOTTKY) F = FULLY ISOLATED -S = SURFACE MT (SMB/SMC) **SUFFIX** (DUAL DESIGNATOR) D = DPAK  $B = D^2PAK$ H = MEGAHERTZ PREFIX KEY MUR = MOTOROLA ULTRA FAST RECTIFIER MBR = MOTOROLA (SCHOTTKY) BARRIER RECTIFIER MR = MOTOROLA STANDARD & FAST RECOVERY CT = CENTER TAP (DUAL) TO-220, TO-3, POWERTAP **SUFFIX KEY** PT = CENTER TAP (DUAL) TO-218 PACKAGE WT = CENTER TAP (DUAL) TO-247 / TO-3P **EXAMPLE: MUR** 30 20 **WT** MOTOROLA ULTRAFAST **30 AMP** 200 V **CENTER TAP (DUAL)** TO-247 **EXAMPLE: MBR** 30 45 WT MOTOROLA SCHOTTKY **30 AMP** 45 V **CENTER TAP (DUAL)** TO-247

## **Application Specific Rectifiers**

The focus for Rectifier Products continues to be on Schottky and Ultrafast technologies, with process and packaging improvements to achieve greater efficiency in high frequency switching power supplies, and high current

mainframe supplies. Our new product thrust is intended to be more "application specific" than in the past, while continuing to strive for broad market acceptance.

### Table 1. Low VF Schottky Rectifiers

State of the art geometry is used in low VF Schottky devices for improved efficiency in low voltage, high frequency switching power supplies, free—wheeling diodes, polarity protection diodes and "OR"ing diodes.

Device	IO Amps	VRRM (Volts)	V <sub>F</sub> <b>@</b> Rated I <sub>O</sub> and Temperature Volts (Max)	IR @ Rated VRRM mAmps (Max)	Package
MBR0520L	0.5	20	0.33	0.25	SOD-123
MBRS130LT3	1	30	0.395	1	SMB
MBRB3030CTL	30	30	0.58	5	D <sup>2</sup> PAK
MBRB2535CTL	25	35	0.41	10	D <sup>2</sup> PAK
MBR2535CTL	25	35	0.41	5	TO-220
MBR/MBRB2515L	25	15	0.42	15	TO-220/D <sup>2</sup> PAK
MBR6030L	60	30	0.38	50	DO-203AB
MBRP20030CTL	200	30	0.39	5	POWERTAP
MBRP60035CTL	600	35	0.50	10	POWERTAP

### **Table 2. MEGAHERTZ Rectifiers**

MEGAHERTZ Series — This group of ultrafast rectifiers is designed to provide improved efficiency in very high frequency switching power supplies and for use in power factor correction circuits.

· · · · · · · · · · · · · · · · · · ·			Maxie	mum	
	I <sub>O</sub> Amps	V <sub>RRM</sub> (Volts)	V <sub>F</sub> <b>©</b> Rated I <sub>O</sub> and Temp. (Volts)	I <sub>R</sub> <b>②</b> Rated VRRM (mAmps)	t <sub>rr</sub> (Nanosecond)
MURH840CT MURH860CT	8 8	400 600	1.7 2.0	0.01 0.01	28 28

### **Table 3. SCANSWITCH Rectifiers**

These ultrafast rectifiers are designed for improved performance in very high resolution monitors and work stations where forward recovery time (t<sub>fr</sub>) and high voltage (1200–1500 volts) are primary considerations.

			Maxi	mum	
Device	I <sub>O</sub> Amps	VRRM (Volts)	t <sub>fr</sub> (Nanoseconds)	t <sub>rr</sub> (Nanoseconds)	V <sub>RFM</sub> (6) (Volts)
MUR5150E	5	1500	225	175	20
MUR880E	8	800		75	
MUR10120E	10	1200	175	175	14
MUR10150E	10	1500	175	175	16
MR10120E	10	1200	175	1000	14
MR10150E	10	1500	175	1000	16

### **Table 4. Automotive Transient Suppressors**

Automotive transient suppressors are designed for protection against over-voltage conditions in the auto electrical system including the "LOAD DUMP" phenomenon that occurs when the battery open circuits while the car is running.

Device	lO	V <sub>RRM</sub>	V(BR)	IRSM <sup>(7)</sup>	τ
	Amps	(Volts)	(Volts)	(Amps)	(°C)
MR2535L	35	20	24-32	110	175

<sup>(5)</sup>Schottky barrier device.

Devices listed in bold, italic are Motorola preferred devices.

<sup>(6)</sup>VRFM = Maximum Transient Overshoot Voltage.

<sup>(7)</sup>Time constant = 10 ms, Duty Cycle ≤ 1%, T<sub>C</sub> = 25°C







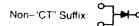
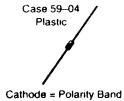


Table 5. Surface Mount Schottky Rectifiers (continued)

V <sub>RRM</sub> (Volts)	I <sub>O</sub> (1) (Amperes)	IO Rating Condition	Device	Max V <sub>F</sub> @ i <sub>F</sub> T <sub>C</sub> = 25°C (Volts)	<sup>I</sup> FSM (Amperes)	T <sub>J</sub> Max (°C)	Package
40	3	T <sub>C</sub> = 125°C	MBRD340	0.60 @ 3.0 A	75	150	DPAK
60	3	T <sub>C</sub> = 125°C	MBRD360	0.60 @ 3.0 A	75	150	DPAK
40	6	T <sub>C</sub> = 130°C	MBRD640CT	0.70 @ 3.0 A	75	150	DPAK
60	6	T <sub>C</sub> = 130°C	MBRD660CT	0.70 @ 3.0 A	75	150	DPAK
35	8	T <sub>C</sub> = 100°C	MBRD835L ★	0.40 @ 3.0 A 0.51 @ 8.0 A	100	125	DPAK
35	10	T <sub>C</sub> = 90°C	MBRD1035CTL*	0.49 @ 10 A	100	125	DPAK
45	15	T <sub>C</sub> = 105°C	MBRB1545CT	0.84 @ 15 A	150	150	D <sup>2</sup> PAK
60	20	T <sub>C</sub> = 110°C	MBRB2060CT	0.95 @ 20 A	150	150	D <sup>2</sup> PAK
100	20	T <sub>C</sub> = 110°C	MBRB20100CT	0.85 @ 10 A 0.95 @ 20 A	150	150	D <sup>2</sup> PAK
200	20	T <sub>C</sub> = 125°C	MBRB20200CT*	1.0 @ 20 A	150	150	D <sup>2</sup> PAK
15 ز	25	T <sub>C</sub> = 90°C	MBRB2515L*	0.45 @ 25 A	150	100	D <sup>2</sup> PAK
35	25	T <sub>C</sub> = 110°C	MBRB2535CTL	0.47 @ 12.5 A 0.55 @ 25 A	150	125	D <sup>2</sup> PAK
45	25	T <sub>C</sub> = 130°C	MBRB2545CT	0.82 @ 30 A	150	150	D <sup>2</sup> PAK
30	30	T <sub>C</sub> = 115°C	MBRB3030CT★	0.51 @ 15 A 0.62 @ 30 A	300	150	D <sup>2</sup> PAK
30	30	T <sub>C</sub> = 95°C	MBRB3030CTL*	0.58 @ 30 A	150	125	D <sup>2</sup> PAK
30	40 evice current capabil	T <sub>C</sub> = 110°C	MBRB4030*	0.53 @ 40 A	300	150	D <sup>2</sup> PAK

IO is total device current capability

<sup>\*</sup> New Product





Case 60-01 Metal Style 1

Cathode = Polarity Band

Table 6. Axial Lead Schottky Rectifiers

V <sub>RRM</sub> (Volts)	I <sub>O</sub> (Amperes)	IO Rating Condition	Device	Max Vr @ ir T <sub>C</sub> = 25°C (Volts)	I <sub>FSM</sub> (Amperes)	T <sub>J</sub> Max (°C)	Case
20	1	T <sub>A</sub> = 55°C R <sub>0</sub> JA = 80°C/W	1N5817	0.45 @ 1.0 A	25	125	59-04
30	1	T <sub>A</sub> = 55°C R <sub>BJA</sub> = 80°C/W	1N5818	0.55 @ 1.0 A	25	125	59-04
40	1	T <sub>A</sub> = 55°C R <sub>BJA</sub> = 80°C/W	1N5819	0.60 @ 1.0 A	25	125	59-04
60	1 -	T <sub>A</sub> = 55°C R <sub>0JA</sub> = 80°C/W	MBR160	0.75 <b>@</b> 1.0 A	25	150	59-04
100	1	T <sub>A</sub> = 120°C R <sub>θJA</sub> = 50°C/W	MBR1100	0.79 @ 1.0 A	50	150	59-04
20	3	T <sub>A</sub> = 76°C R <sub>BJA</sub> = 28°C/W	1N5820	0.457 <b>@</b> 3.0 A	80	125	267-03
30	3	T <sub>A</sub> = 71°C R <sub>BJA</sub> = 28°C/W	1N5821	0.500 @ 3.0 A	80	125	26703
40	3	T <sub>A</sub> = 61°C R <sub>BJA</sub> = 28°C/W	1N5822	0.525 @ 3.0 A	80	125	267-03
40	3	T <sub>A</sub> = 65°C R <sub>θJA</sub> = 28°C/W	MBR340	0.600 @ 3.0 A	80	150	267-03
60	3	T <sub>A</sub> = 65°C R <sub>0JA</sub> = 28°C/W	MBR360	0.740 <b>@</b> 3.0 A	80	150	267-03
100	3	T <sub>A</sub> = 100°C R <sub>0JA</sub> = 28°C/W	MBR3100	0.79 <b>@</b> 3.0 A	150	150	26703
20	5	T <sub>A</sub> = 30°C R <sub>0</sub> JA = 25°C/W	1N5823	0.360 @ 5.0 A	500	125	60-01
30	5	T <sub>A</sub> = 40°C R <sub>BJA</sub> = 25°C/W	1N5824	0.370 <b>@</b> 5.0 A	500	125	6001
40	5	T <sub>A</sub> = 45°C R <sub>BJA</sub> = 25°C/W	1N5825	0.380 <b>9</b> 5.0 A	500	125	60-01

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absolute maximum ratings over operating temperature ranges (unless otherwise noted)
Input voltage, V <sub>I</sub> : µA7824C
the daylog. These are stress ratings only, and

Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and "unctional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not under the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not under the device reliability.

For operation above 25°C free-air or 90°C case temperature, refer to Figures 1 and 2. To avoid exceeding the design maximum virtual junction temperature, these ratings should not be exceeded. Due to variations in individual device electrical characteristics and thermal resistance, the built-in thermal overload protection may be activated at power levels slightly above or below the rated dissipation.

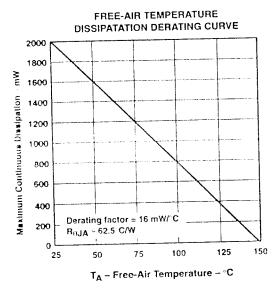


Figure 1

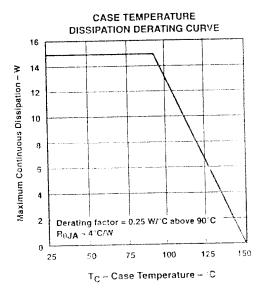


Figure 2

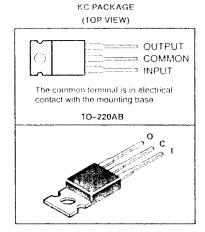
## $\mu \text{A7800 SERIE\$} \\ \text{POSITIVE-VOLTAGE REGULATOR\$}$

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- 3-Terminal Regulators
- Output Current Up to 1.5 A
- Internal Thermal Overload Protection
- High Power Dissipation Capability
- Internal Short-Circuit Current Limiting
- Output Transistor Safe-Area Compensation
- Direct Replacements for Fairchild μA7800 Series

#### description

This series of fixed-voltage monolithic integratedcircuit voltage regulators is designed for a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. Each of these regulators can deliver up



to 1.5 A of output current. The internal current limiting and thermal shutdown features of these regulators make them essentially immune to overload. In addition to use as fixed-voltage regulators, these devices can be used with external components to obtain adjustable output voltages and currents and also used as the power-pass element in precision regulators.

The  $\mu$ A7800C series is characterized for operation over the virtual junction temperature range of 9°C to 125°C. The  $\mu$ A7805Q and  $\mu$ A7812Q are characterized for operation over the virtual junction temperature range of -40°C to 125°C.

#### AVAILABLE OPTIONS

	V	PACKAGED DEVICES	CHIP FORM
Tj	V <sub>O(nom)</sub> (V)	PLASTIC FLANGE-MOUNT (KC)	(Y)
	5	μΑ7805CKC	μ <b>Α</b> 7805Υ
	6	μΑ7806CKC	μΑ7806Y
	8	µA7808CKC	μΑ780 <b>8</b> Υ
	8.5	μΑ7885CKC	11A7885Y
0°C to 125°C	10	μΑ7810CKC	;iA7810Y
	12	uA7812CKC	μA7812Y
ļ .	15	цА7815CKC	иA7815Y
	18	::A7818CKC	нА7818Ү
	24	пА7824СКС	μΑ7824Υ
-40 C to 125 C	5	нА7805QKC	
-40 C to 125 C	12	uA7812QKC	

PRODUCTION DATA information is current as of publication data. Products conform to specifications per the terms of Texas instruments stendard warranty. Production processing does not necessarily include testing of all parameters.

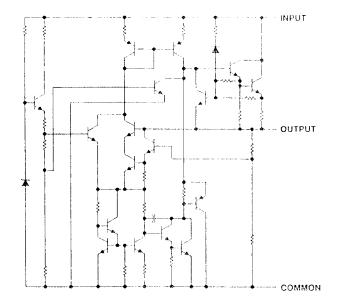


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schematic





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recommended operating conditions

ecommended operating conditions		MIN	MAX	UNIT
	µA7805C	7	25	
	иА7806C	8	25	
nput voltage, V <sub>I</sub>	μΑ7808C	10.5	25	
	μA7885C	10.5	25	
	μΑ7810C	12.5	28	٧
	µА7812С	14.5	30	]
	μΑ7815C	17.5	30	]
	μΑ7818C	21	33	]
	μΑ7824C	27	38	
			1.5	A
Output current, IO	µA7800C Series	0	125	_ ∘c
Operating virtual junction temperature, TJ	μΑ7805Q, μΑ7812Q	-40	125	

electrical characteristics at specified virtual junction temperature,  $V_1 = 10 \text{ V}$ ,  $I_0 = 500 \text{ mA}$  (unless otherwise noted)

therwise noted)			μ <b>A78</b> 05	805Q	UNIT	
PARAMETER	TEST CONDITIONS	TJ <sup>†</sup>	MIN	TYP	MAX	
		25°C	4.8	5	5.2	
Dutput voltage‡	$I_{O} = 5 \text{ mA to 1 A}$ , $V_{I} = 7 \text{ V to 20 V}$ . P $\leq 15 \text{ W}$	Full range§	4.75		5.25	· · · · ·
	V <sub>I</sub> = 7 V to 25 V	25°C		3	100	mV
input voltage regulation	V <sub>1</sub> = 8 V to 12 V	250		1	50	
	V <sub>1</sub> = 8 V to 18 V. f = 120 Hz	Full range§	62	78		dB
Ripple rejection	I <sub>O</sub> = 5 mA to 1.5 A	2570		15	100	mV
Output voltage regulation	IO = 250 mA to 750 mA	25°C		5	50	
	f = 1 kHz	Full range§		0.017		Ω
Output resistance		Full range§	1	-1.1		mV/°C
Temperature coefficient of output voltage	1 <sub>O</sub> = 5 mA	25°C		40		μV
Output noise voltage	f = 10 Hz to 100 kHz	25°C	<del> </del>	2		V
Dropout voltage	IO = 1 A	25°C		4.2	8	mA
Bias current		25 0	<del> </del>		1.3	<del>                                     </del>
	V <sub>I</sub> = 7 V to 25 V	Full range§			0.5	- mA
Bias current change	I <sub>O</sub> = 5 mA to 1 A			750		mA
Short-circuit output current		25^C	<del> </del>	2.2		A
	etion tomperature as close to the ambient terr	25°C	la Thorr			

<sup>†</sup> Pulso-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

§ Full range virtual junction temperature is 0°C to 125°C for the μA7805C and ~40°C to 125°C for the μA7805G.

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### electrical characteristics at specified virtual junction temperature, $V_I$ = 11 V, $I_O$ = 500 mA (unless otherwise noted)

			- +	μ.	A7806C		UNIT	
PARAMETER	TEST CONDITIONS		TJ <sup>†</sup>	MIN	TYP	MAX	ONLI	
			25 C	5.75	6	6.25		
Output voltage‡	$I_O \approx 5$ mA to 1 A, P $\leq$ 15 W	V <sub>I</sub> = 8 V to 21 V,	0°C to 125°C	5.7		6.3	٧	
	V <sub>1</sub> = 8 V to 25 V		25°C		5	120	m∨	
Input voltage regulation	V <sub>I</sub> ≈ 9 V to 13 V		25 0		1.5	60		
Ripple rejection	$V_1 = 9 \text{ V to } 19 \text{ V}$	f = 120 Hz	0°C to 125°C	59	75		dB	
	IO = 5, mA to 1.5 A		2520		14	120	Vm	
Output voltage regulation	t voltage regulation I <sub>O</sub> = 250 mA to 750 mA		4	60	1117			
Output resistance	f = 1 kHz		0°C to 125°C		0.019		Ω	
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA		0°C to 125°C		-0.8		mV/°C	
Output noise voltage	1 = 10 Hz to 100 kHz		25°C		45		μV	
Dropout voltage	I <sub>O</sub> = 1 A		25°C		2		V	
Bias current			25 °C		4.3	8	mA	
	V <sub>1</sub> = 8 V to 25 V		0°C to 125°C			1.3	mA	
Bias current change	I <sub>O</sub> = 5 mA to 1 A		0 0 10 125 0			0.5		
Short-circuit output current			25°C		550		mA	
Peak output current			25°C		2.2		A	

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33- $\mu F$  capacitor across the input and a 0.1- $\mu F$  capacitor across the output.

‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

### electrical characteristics at specified virtual junction temperature, $V_I$ = 14 V, $I_O$ = 500 mA (unless otherwise noted)

		- +	μ <b>Α</b> 7808C			UcilT
PARAMETER	TEST CONDITIONS	t <sub>U</sub> T	MIN	TYP	MAX	Unital
		25°C	7.7	8	8.3	
Output voltage <sup>‡</sup>	$I_O = 5 \text{ mA to 1 A}, \qquad V_I = 10.5 \text{ V to 23 V},$ P $\leq$ 15 W	0°C to 125°C	7.6		8.4	У
	V <sub>j</sub> = 10.5 V to 25 V	25°C		6	160	m۷
Input voltage regulation	V <sub>I</sub> = 11 V to 17 V	25 C		2	80	111.4
Ripple rejection	V <sub>1</sub> = 11.5 V to 21.5 V, f = 120 Hz	0°C to 125°C	55	72		₫₿
	I <sub>O</sub> = 5 mA to 1.5 A	25°C		12	160	mV
Output voltage regulation	I <sub>O</sub> = 250 mA to 750 A			4	80	1114
Output resistance	f = 1 kHz	0°C to 125°C		0.016		Ω
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA	0°C to 125°C		-0.8		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25 C		52		şιV
Dropout voltage	I <sub>O</sub> = 1 A	25 C		2		V
Bias current		25°C		4.3	8	mA
	V <sub>I</sub> = 10.5 V to 25 V	0°C to 125°C			1	mA
Bias current change	I <sub>O</sub> = 5 mA to 1 A	0 0 10 123 0			0.5	
Short-circuit output current		25°C		450		mA
Peak output current		25°C		2.2		A

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

† This specification applies only for do power dissipation permitted by absolute maximum ratings.



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## electrical characteristics at specified virtual junction temperature, $V_1$ = 15 V, $I_O$ = 500 mA (unless

PARAMETER	TEST CONDITIONS	T +	jt	A7885C		
FARAMETER	TEST COMDITIONS	TJ <sup>†</sup>	MIN	TYP	MAX	UNIT
		25 C	8.15	8.5	8.85	
Output voltage‡	$I_O = 5 \text{ mA to 1 A}, \qquad V_1 = 11 \text{ V to 23 5 V}.$ P $\leq$ 15 W	0°C to 125°C	8.1		8.9	V
Input voltage regulation	V <sub>I</sub> = 10.5 V to 25 V	05:0		6	170	.,
input voitage regulation	V <sub>1</sub> = 11 V to 17 V	25 °C		2	85	m∨
Ripple rejection	V <sub>I</sub> = 11.5 V to 21.5 V, f = 120 Hz	0°C to 125°C	54	70		dΒ
Output voltage regulation	I <sub>O</sub> = 5 mA to 1.5 A	25°C	05.0	12	170	.,
Output voltage regulation	I <sub>O</sub> = 250 mA to 750 mA			4	85	m∀
Output resistance	f = 1 kHz	0 °C to 125 °C		0.016		Ω
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA	0 C to 125 C		-0.8		mV/:3
Output noise voltage	f = 10 Hz to 100 kHz	25°C		55		μV
Dropout voltage	I <sub>O</sub> = 1 A	25°C		2		V
Bias current		25°C		4.3	3	mA
Diag ourset shares	V <sub>I</sub> = 10.5 V to 25 V	6.665.6			1 .	
Bias current change	1 <sub>O</sub> = 5 mA to 1 A	0°C to 125°C			0.5	mA
Short-circuit output current		25 °C		450		mA
Peak output current		25°C		2.2		A

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

† This specification applies only for do power dissipation permitted by absolute maximum ratings.

## electrical characteristics at specified virtual junction temperature, $V_1$ = 17 V, $I_O$ = 500 mA (unless otherwise noted)

PARAMETER	TEST COMPLIANCE	- t	μ <b>Α7810C</b>			
PAHAMETEH	TEST CONDITIONS	Tu <sup>†</sup>	MIN	TYP	MAX	UNIT
		25 °C	9.6	10	10.4	
Output voltage‡	$I_O = 5$ mA to 1 A, $V_I = 12.5$ V to 25 V, $P \le 15$ W	0° C to 125° C	9.5	10	10.5	٧
Input voltage regulation	V <sub>1</sub> = 12.5 V to 28 V	0500		7	200	
Input voltage regulation	V <sub>I</sub> = 14 V to 20 V	25°C		2	100	m∀
Ripple rejection	V <sub>I</sub> = 13 V to 23 V, 1 ≈ 120 Hz	0°C to 125°C	55	71		d₽
Output valiance and delica	I <sub>O</sub> = 5 mA to 1.5 A	25:0		12	200	
Output voltage regulation	IO = 250 mA to 750 mA	25 C		4	100	m∀
Output resistance	f = 1 kHz	0 C to 125 C		0.018		12
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA	0°C to 125°C		- 1		mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C		70		jtV
Dropout voltage	I <sub>O</sub> = 1 A	25°C		2		٧
Bias current		<b>2</b> 5 °C		4.3	8	mA
Dies surrent change	V <sub>I</sub> = 12.5 V to 28 V	000 4- 10500			1	A
Bias current change	I <sub>O</sub> = 5 mA to 1 A	0°C to 125°C			0.5	m.A
Short-circuit output current		25°C		400		mΑ
Peak output current		25 °C		2.2		A

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

† This specification applies only for do power dissipation permitted by absolute maximum ratings.





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### electrical characteristics at specified virtual junction temperature, $V_{I}$ = 19 V, $I_{O}$ = 500 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	<sub>T.t</sub>	μ			
		τ <sub>J</sub> t	MIN	TYP	MAX	TINU
Output voltage‡		25°C	11.5	12	12.5	<del>                                     </del>
zuipiti voitage+	$I_0 = 5 \text{ mA to 1 A}, \qquad V_1 = 14.5 \text{ V to 27 V},$ P $\leq 15 \text{ W}$	Full range§	11.4		12.6	V
Input voltage regulation	V <sub>I</sub> = 14.5 V to 30 V			10	240	
- The state of the	V <sub>I</sub> = 16 V to 22 V	25°C		3	120	m∨
Ripple rejection	V <sub>I</sub> = 15 V to 25 V, f = 120 Hz	Full range§	55	71	120	dB
Output voltage regulation	10 = 5 mA to 1.5 A	- and anger	-	12	240	UB
	IO = 250 mA to 750 mA	25°C		4	120	mV
Output resistance	f = 1 kHz	Full range§		0.018	120	
Temperature coefficient of output voltage	IO = 5 mA	Full range§	<del></del>			Ω
Output noise voltage	f = 10 Hz to 100 kHz	25°C		-1		mV/°C
Dropout voltage	I <sub>O</sub> = 1 A			75		μV
Bias current	<u> </u>	25°C		2		V
	V <sub>I</sub> = 14.5 V to 30 V	25°C		4.3	8	±nA
Bias current change	I <sub>O</sub> = 5 mA to 1 A	Full range§			1	mA
Short-circuit output current	IO - S IIIA IO I A				0.5	11174
Peak output current		25°C		350		mA
Polar to d'		25°C		2.2		Д

Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

### electrical characteristics at specified virtual junction temperature, $V_1$ = 23 V, $I_O$ = 500 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	T.+	μ	T		
		⊤√t	MIN	TYP	MAX	UNIT
Output voltage‡		25"C	14.4	15	15.6	<u> </u>
Output voltage+	$I_{O} = 5 \text{ mA to 1 A}, \qquad V_{I} = 17.5 \text{ V to 30 V}$ P $\leq$ 15 W	0°C to 125°C	14.25		15.75	V
Input voltage regulation	V <sub>1</sub> = 17.5 V to 30 V	<b> </b>	ļ	11	300	<del> </del>
	V <sub>I</sub> = 20 V to 26 V	25°C	<del></del>	3	150	mV
Ripple rejection	V <sub>I</sub> = 18.5 V to 28.5 V, f = 120 Hz	0°C to 125°C	54	70	150	
Output voltage regulation	1 <sub>O</sub> = 5 mA to 1.5 A	0 0 10 123 0	- 34	12	200	₫B
	I <sub>O</sub> = 250 mA to 750 mA	25°C	ļ	4	300	mV
Output resistance	f = 1 kHz	0°C to 125°C		<u> </u>	150	
Temperature coefficient of output voltage	10 = 5 mA	0°C to 125°C		0.019		Ω
Output noise voltage	f = 10 Hz to 100 kHz			-1		mV/°C
Dropout voltage	<del></del>	25°C		90		μV
Bias current	I <sub>O</sub> = 1 A	25°C		2		V
Dias current		25°C		4.4	8	mA
Bias current change	V <sub>I</sub> = 17.5 V to 30 V					
	I <sub>O</sub> = 5 mA to 1 A	0°C to 125°C			0.5	mΑ
Short-circuit output current		25°C		000	V.5	
Peak output current		25°C		230		mA_
Pulse-testing techniques maintain the	<u> </u>	23 C		2.1	i	A.

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.



<sup>†</sup> This specification applies only for dc power dissipation permitted by absolute maximum ratings

<sup>§</sup> Full range virtual junction temperature is 0°C to 125°C for the μΑ7812C and –40°C to 125°C for the μΑ7812Q.

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### electrical characteristics at specified virtual junction temperature, $V_{I}$ = 27 V, $I_{O}$ = 500 mA (unless otherwise noted)

PARAMETER	TEST CONDITIONS	- t	μ.			
FARAMETER	TEST CONDITIONS	TJ <sup>†</sup>	MIN	TYP	MAX	TIMU
		25°C	17.3	18	18.7	
Dutput voltage‡	$I_O = 5$ mA to 1 A, $V_I = 21$ V to 33 V, $P \le 15$ W	0°C to 125°C	17.1		18.9	V
Input voltage regulation	V <sub>I</sub> = 21 V to 33 V	95.0		15	360	
input voltage regulation	V <sub>I</sub> = 24 V to 30 V	25 °C		5	180	mV
Ripple rejection	V <sub>I</sub> = 22 V to 32 V, f = 120 Hz	0°C to 125°C	53	69		dB
Output vallage services	I <sub>O</sub> = 5 mA to 1.5 A	04.0		12	360	mV
Output voltage regulation	IO = 250 mA to 750 mA	25 C		4	180	
Output resistance	f = 1 kHz	0°C to 125°C		0.022		Ω
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA	0°C to 125°C		<b>– 1</b>		mV/°C
Output noise voltage -	f = 10 Hz to 100 kHz	25 C		110		μV
Dropout voltage	1 <sub>O</sub> = 1 A	25°C	······	2		V
Bias current		25 °C		4.5	8	mA
Dian automatabases	V <sub>1</sub> = 21 V to 33 V				1	
Bias current change	I <sub>O</sub> = 5 mA to 1 A	0°C to 125°C			0.5	mA
Short-circuit output current		25°C		200		mA
Peak output current		25°C		2.1		А

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-uF capacitor across the input and a 0.1-uF capacitor across the output.

† This specification applies only for do power dissipation permitted by absolute maximum ratings.

### electrical characteristics at specified virtual junction temperature, $V_1 = 33 \text{ V}$ , $I_0 = 500 \text{ mA}$ (unless otherwise noted)

PARAMETER	TEST COMPLETONS	++	μ <b>Α</b> 78	24C	T
FARAMETER	TEST CONDITIONS	TJ <sup>†</sup>	MIN T	YP MAX	UNIT
Output voltage‡		25 °C	23	24 25	
	$I_O = 5 \text{ mA to 1 A}, \qquad V_J = 27 \text{ V to } 38 \text{ V},$ P $\leq$ 15 W	0°C to 125°C	22.8	25.2	\ \
land values regulation	V <sub>1</sub> = 27 V to 38 V	0500		18 480	
Input voltage regulation	V <sub>1</sub> = 30 V to 36 V	25°C		6 240	mV
Ripple rejection	$V_1 = 28 \text{ V to } 38 \text{ V}, \qquad f = 120 \text{ Hz}$	0°C to 125°C	50	66	dB
Output valters are dating	I <sub>O</sub> = 5 mA to 1.5 A	2500		12 480	VmV
Output voltage regulation	1 <sub>O</sub> = 250 mA to 750 mA	- 25°C		4 240	
Output resistance	f = 1 kHz	0°C to 125°C	0.0	28	Ω
Temperature coefficient of output voltage	1 <sub>O</sub> = 5 mA	0°C to 125°C		1.5	mV/°C
Output noise voltage	f = 10 Hz to 100 kHz	25°C	1	70	μ٧
Dropout voltage	I <sub>O</sub> = 1 A	25°C		2	V
Bias current		25°C		1.6 8	mA
Discount	V <sub>I</sub> = 27 V to 38 V			1	T
Bias current change	I <sub>O</sub> = 5 mA to 1 A	0°C to 125°C		0.5	mA
Short-circuit output current		25°C	1	50	mA
Peak output current		25 °C		2.1	A

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

<sup>‡</sup> This specification applies only for dc power dissipation permitted by absolute maximum ratings.





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### electrical characteristics at specified virtual junction temperature, $V_J$ = 10 V, $I_O$ = 500 mA, $T_J$ = 25 $\,$ C $^{\dagger}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS	μ <b>Α</b> 7805Υ		
	TEST CONDITIONS	MIN TYP MAX	TIMU	
Output voltage‡		5	T V	
Input voltage regulation	V <sub>1</sub> = 7 V to 25 V	3	<del>                                     </del>	
	V <sub>I</sub> = 8 V to 12 V	1	m∨	
Ripple rejection	V <sub>1</sub> = 8 V to 18 V,	78	dB	
Output voltage regulation	I <sub>O</sub> = 5 mA to 1.5 A	15		
Solpat Vonage regulation	IO = 250 mA to 750 mA	5	m∀	
Output resistance	f = 1 kHz	0.017	Ω	
Temperature coefficient of output voltage	IO = 5 mA	-1.1	mV/ C	
Output noise voltage	f = 10 Hz to 100 kHz	40	μV	
Dropout voltage	IO = 1 A	2	V	
Bias current		4.2		
Short-circuit output current			mA	
Peak output current		750	mA	
- Cart Colpat Carrent		2.2	Α	

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

## electrical characteristics at specified virtual junction temperature, $V_I$ = 11 V, $I_O$ = 500 mA, $T_J$ = 25°C† (unless otherwise noted)

PARAMETER	TEST CONDITIONS	μ <b>Α</b> 7806Υ	1	
	7651 OCHOITIONS	MIN TYP MAX	UNIT	
Output voltage‡		6	V	
Input voltage regulation	V <sub>I</sub> = 8 V to 25 V	5		
	V <sub>1</sub> = 9 V to 13 V	1.5	mV	
Ripple rejection	$V_1 = 9 \text{ V to } 19 \text{ V}, \qquad f = 120 \text{ Hz}$	75	dB	
Output voltage regulation	I <sub>O</sub> = 5 mA to 1.5 A	14		
	IO = 250 mA to 750 mA	4	m∀	
Output resistance	f = 1 kHz	0.019	Ω	
Temperature coefficient of output voltage	1 <sub>O</sub> = 5 mA	-0.8	mV/ C	
Output noise voltage	f = 10 Hz to 100 kHz	45	uV	
Dropout voltage	Io = 1 A	2	V V	
Bias current		4.3		
Short-circuit output current			inA .	
Peak output current		550	mA	
		2.2	Α	

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

† This specification applies only for dc power dissipation permitted by absolute maximum ratings.



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### electrical characteristics at specified virtual junction temperature, $V_1 = 14 \text{ V}$ , $I_O = 500 \text{ mA}$ , $T_J = 25^{\circ}\text{C}^{\dagger}$ (unless otherwise noted)

uniess otherwise noted)		μΑ7808Υ	UNIT
PARAMETER	TEST CONDITIONS	MIN TYP MA	X
Output voltage		8	V
Odiput voltage v	V <sub>I</sub> = 10.5 V to 25 V	6	
Input voltage regulation	V <sub>1</sub> = 11 V to 17 V	2	
Ripple rejection	V <sub>1</sub> = 11.5 V to 21.5 V, f = 120 Hz	72	dB
Hippie rejoction	IO = 5 mA to 1.5 A	12	mv
Output voltage regulation	IO = 250 mA to 750 A	4	
Output resistance	f = 1 kHz	0.016	Ω
Temperature coefficient of output voltage	I <sub>O</sub> = 5 mA	-0.8	mV/^0
Output noise voltage	f = 10 Hz to 100 kHz	52	μV
Dropout voltage	1 <sub>O</sub> = 1 A	2	
Bias current		4.3	mA
Short-circuit output current		450	mA
Peak output current		2.2	A

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.

## electrical characteristics at specified virtual junction temperature, $V_I$ = 15 V, $I_O$ = 500 mA, $T_J$ = 25 $^\circ$ C $^\dagger$ (unless otherwise noted)

		μ <b>Α7885</b> Υ	UNIT	
PARAMETER	TEST CONDITIONS	MIN TYP MAX	UIST	
Output voltage		8.5	V	
Odipat voltago.	V <sub>I</sub> = 10.5 V to 25 V	6	mV	
Input voltage regulation	V <sub>I</sub> = 11 V to 17 V	2		
Ripple rejection	V <sub>I</sub> = 11.5 V to 21.5 V, f = 120 Hz	70	dB	
rippie rejection	IO = 5 mA to 1.5 A	12	mV.	
Output voltage regulation	IO = 250 mA to 750 mA	4		
Output resistance	f = 1 kHz	0.016	Ω	
Temperature coefficient of output voltage	10 = 5 mA	-0.8	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	55	μV	
Dropout voltage	10 = 1 A	2	V	
		4.3	mA	
Bias current		450	mΛ	
Short-circuit output current		2.2	A	
Peak output current	and a place to the ambient temperature as po		a takon i	

T Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-μF capacitor across the input and a 0.1-μF capacitor across the output.
 This specification applies only for dc power dissipation permitted by absolute maximum ratings.



<sup>‡</sup> This specification applies only for do power dissipation permitted by absolute maximum ratings.

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## electrical characteristics at specified virtual junction temperature, $V_J = 17 \text{ V}$ , $I_O = 500 \text{ mA}$ , $T_J = 25 ^{\circ}\text{CT}$ (unless otherwise noted)

PARAMETER	TECT COMPA	Azola	
Cutput voltage	TEST CONDITIONS	μΑ7810Υ	UNIT
		MIN TYP MAX	O INT
Input voltage regulation	V <sub>1</sub> = 12.5 V to 28 V	10	V
Ripple rejection	V <sub>I</sub> = 14 V to 20 V	7	
	V <sub>I</sub> = 13 V to 23 V,	2	m∀
Output voltage regulation	O = 5 mA to 1.5 A	71	dB
Output resistance	IO = 250 mA to 750 mA	12	
Temperature coefficient of output voltage	1 : 1 kHz	4	mV
Output noise voltage	I <sub>O</sub> = 5 mA	0.018	Ω
Propout voltage	f = 10 Hz to 100 kHz	-1	mV/^C
Bias current	IO = 1 A	70	μV
hort-circuit output current		2	٧
eak output current		4.3	mA
Pulse-testing techniques maintain	erature as close to the ambient temperature as possib	400	mA
secount separately All shares in the junction temp	erature as close to the ambiguit	2.2	A

Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. ‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.

# electrical characteristics at specified virtual junction temperature, $V_I = 19 \text{ V}$ , $I_O = 500 \text{ mA}$ , $T_{.J} = 25 ^{\circ}\text{C}^{\dagger}$

PARAMETER Output voltage‡	TEST CONDITIONS	μA7812Y	T
		MIN TYP MAX	TIMU
Input voltage regulation	VI = 14.5 V to 30 V	12	V
Ripple rejection	V <sub>I</sub> = 16 V to 22 V	10	
0	$V_1 = 15 \text{ V to } 25 \text{ V}, \qquad f = 120 \text{ Hz}$	3	mV
Dutput voltzge regulation	10 = 5 mA to 1.5 A	71	₫B
Output resistance	IO = 250 mA to 750 mA	12	·
Temperature coefficient of output voltage	f = 1 kHz	4	Fi. '
Output noise voltage	IO = 5 mA	0.018	Ω
Dropout voltage	f = 10 Hz to 100 kHz	-1	mV/°C
Bias current	10 = 1 A	75	μV
hort-circuit output current		2	V
eak output current		4.3	mA
Pulse-testing techniques	erature as close to the ambient temperature as cossil	350	mA
ccount senarately. All all	erature as close to the auto	2.2	A

Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output. ‡ This specification applies only for do power dissipation permitted by absolute maximum ratings.



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## electrical characteristics at specified virtual junction temperature, $V_I$ = 33 V, $I_O$ = 500 mA, $T_J$ = 25°C† (unless otherwise noted)

PARAMETER	TEST CONDITIONS	μ <b>Α7824</b> Υ		
	TEST CONDITIONS	MIN TYP MAX	UNIT	
Output voltage <sup>‡</sup>		24	V	
Input voltage regulation	V <sub>I</sub> = 27 V to 38 V	18	<b>†</b>	
mput voltage regulation	V <sub>1</sub> = 30 V to 36 V	6	m∨	
Ripple rejection	$V_1 = 28 \text{ V to } 38 \text{ V}, \qquad f = 120 \text{ Hz}$	66	dB	
Output voltage regulation	I <sub>O</sub> ≈ 5 mA to 1.5 A	12	mV	
	IO = 250 mA to 750 mA	4		
Output resistance .	f = 1 kHz	0.028	Ω	
Temperature coefficient of output voltage	1 <sub>O</sub> = 5 mA	-1.5	mV/°C	
Output noise voltage	f = 10 Hz to 100 kHz	170	μ٧	
Dropout voltage	I <sub>O</sub> = 1 A	2	V	
Bias current	المجال	4.6	mA	
Short-circuit output current	Type -	150	mA	
Peak output current		2.1	A	

<sup>†</sup> Pulse-testing techniques maintain the junction temperature as close to the ambient temperature as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 0.33-µF capacitor across the input and a 0.1-µF capacitor across the output.

‡ This specification applies only for dc power dissipation permitted by absolute maximum ratings.



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### **APPLICATION INFORMATION**

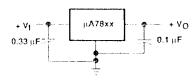


Figure 3. Fixed Output Regulator

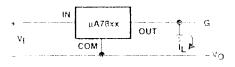
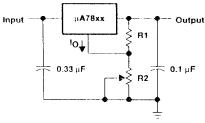


Figure 4. Positive Regulator in Negative Configuration (V<sub>I</sub> Must Float)



NOTE A. The following formula is used when Vxx is the nominal output voltage (output to common) of the fixed regulator.

$$V_{O} = V_{xx} + \left(\frac{V_{xx}}{R1} + I_{Q}\right) R2$$

Input  $\mu A78xx$   $O.33 \mu F$  VO(Reg)  $I_{O} = (V_{O}/R1) + I_{O} \text{ Bias Current}$ 

Figure 5. Adjustable Output Regulator

Figure 6. Current Regulator

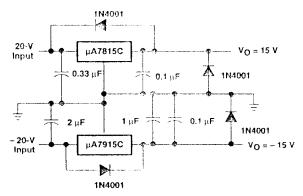


Figure 7. Regulated Dual Supply

Case 56 (DO 203AA)



Case 257 (DO 203AB)



Case 11-03 (TO 204AA)



CACE COMMON CATHODE

5 VIOUE #5

5 NOOE #5

Table 9. TO-204AA (formerly TO-3), DO-203AA and DO-203AB (formerly DO-4 and DO-5) Schottky Rectifier Metal Packages

V <sub>RRM</sub> (Volts)	I <sub>O</sub> (Amperes)	IO Rating Condition	Devic <del>e</del>	Max V <sub>F</sub> @ iF T <sub>C</sub> = 25 C (Volts)	I <sub>FSM</sub> (Amperes)	Tj Max (∵C)	Case
20	15	T <sub>C</sub> = 85°C (V <sub>R</sub> = 4 V)	1N5826	0.44 13 15 A	500	125	56
30	15	T <sub>C</sub> = 85°C (V <sub>R</sub> = 6 V)	1N5827	0.47 @ 15 A	500	125	56
40	15	T <sub>C</sub> = 85°C (V <sub>R</sub> = 8 V)	1N5828	0.50 æ 15 A	500	125	56
20	25	T <sub>C</sub> = 85°C (V <sub>R</sub> = 4 V)	1N5829	0.44 3 25 A	800	125	56
30	25	T <sub>C</sub> = 85°C (V <sub>R</sub> = 6 V)	1N5830	0.46 ₱ 25 A	800	125	56
40	25	T <sub>C</sub> = 85 °C (V <sub>R</sub> = 8 V)	1N5831	0.48 @ 25 A	800	125	56
30	25	T <sub>C</sub> = 70°C	1NG095	0.86 @ 78.5 A T <sub>C</sub> = 70 C	400	125	55
40	25	T <sub>C</sub> = 70 C	1N6096	0.86 ≈ 78.5 A T <sub>C</sub> = 70 C	400	125	5\$
45	30	T <sub>C</sub> = 105 C	SD41	0.55 @ 78 5 A T <sub>C</sub> = 125 C	600	150	56
45	35	T <sub>C</sub> = 110°C	MBR3545	0.63 @ 35 A	600	150	56
20	40	T <sub>C</sub> = 75 C (V <sub>R</sub> = 4 V)	1N5832	0.052 ℜ 40 A	800	125	257
30	40	T <sub>C</sub> = 75°C (V <sub>R</sub> = 6 V)	1N5833	0.55 æ 40 A	800	125	257
40	40	T <sub>C</sub> = 75 C (V <sub>R</sub> = 8 V)	1N5834	0.59 @ 40 A	800	125	257
30	50	T <sub>C</sub> = 70 °C	1N6097	0.86 ⊉ 157 A T <sub>C</sub> = 70 C	800	125	257
40	50	T <sub>C</sub> = 70 C	1N6098	0.86 ≩ 157 A T <sub>C</sub> = 70 C	800	125	257
30	60	T <sub>C</sub> = 120 °C	MBR6030L	0.42 @ 30 A 0.48 @ 60 A	1000	150	257
45	60	T <sub>C</sub> = 90 °C	SD51	0.70 © 60 A	800	150	257
45	60	T <sub>C</sub> = 100 °C	MBR6045	0.70 @ 60 A	800	150	257
45	65	T <sub>C</sub> = 120 C	MBR6545	0.78 ₫ 65 A	800	175	2.57
45	75	T <sub>C</sub> = 90 °C	мвя7545	0 60	1000	150	257
45	80	T <sub>C</sub> = 120 C	MBR8045	0.72 @ 80 A	1000	175	257
45	30	T <sub>C</sub> = 105 °C	MBR3045CT	0.76 ➪ 30 A	400	150	1103
45	30	T <sub>C</sub> = 105 °C	SD241	0 60 ଛ 20 A T <sub>C</sub> = 125 C	400	150	11-03

Devices fisted in bold, italic are Motorola preferred devices.

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Rectifiers



### Zener Diodes Voltage Regulator Diodes (continued)

Table 13. Axial Leaded for Through-hole Designs - 500 mW (continued)

Nominal Zener Breakdown Voltage	500 mW Cathode = Polarity Band	500 mW Low Level Cathode = Polarity Band	500 mW Cathode = Polarity Band					500 mW Low Level Cathode = Polarity Band	500 r Cathode = Bar	Polarity
(*Note 1)	(*Note 2)	(*Note 3)	(*Note 4)	(*Note 5)	(*Note 6)	(*Note 7)	(*Note 8)	(*Note 9)	(*Note 10)	(*Note 8)
Volts						DO	Glass ase 299 D-204AH DO-35)			
19 20 22 24 25	1N968B 1N969B 1N970B	1N4706 1N4707 1N4708 1N4709 1N4710	1N5249B 1N5250B 1N5251B 1N5252B 1N5253B	1N6007B 1N6008B 1N6009B	BZX55C20RL BZX55C22RL BZX55C24RL	BZX79C20RL BZX79C22RL BZX79C24RL	BZX83C20RL BZX83C22RL BZX83C24RL BZX83C27RL			ZPD20RL ZPD22RL ZPD24RL ZPD27RL
27 28 30	1N971B 1N972B	1N4711 1N4712 1N4713	1N5254B 1N5255B 1N5256B	1N6010B	BZX55C27RL BZX55C30RL	BZX79C27RL  BZX79C30RL	BZX83C27RL			ZPD30RL
33 36 39 43	1N973B 1N974B 1N975B 1N976B	1N4714 1N4715 1N4716 1N4717	1N5257B 1N5258B 1N5259B 1N5260B	1N6012B 1N6013B 1N6014B 1N6015B	BZX55C33RL BZX55C36RL BZX55C39RL BZX55C43RL	BZX79C33RL BZX79C36RL BZX79C39RL BZX79C43RL	BZX83C33RL			ZPD33RL
47 51 56 60 62 68	1N977B 1N978B 1N979B 1N980B 1N981B		1N5261B 1N5262B 1N5263B 1N5264B 1N5265B 1N5266B	1N6016B 1N6017B 1N6018B 1N6019B 1N6020B	BZX55C47RL BZX55C51RL BZX55C56RL BZX55C62RL BZX55C68RL	BZX79C47RL BZX79C51RL BZX79C56RL BZX79C62RL BZX79C68RL				
75 82 87 91	1N982B 1N983B 1N984B		1N5267B 1N5268B 1N5269B 1N5270B	1N6021B 1N6022B 1N6023B	BZX55C75RL BZX55C82RL BZX55C91RL	BZX79C75RL BZX79C82RL BZX79C91RL				
100 110 120 130 140 150	1N985B 1N986B 1N987B 1N988B		1N5271B 1N5272B 1N5273B 1N5274B 1N5275B 1N5276B	1N6024B 1N6025B		BZX79C100RL BZX79C110RL BZX79C120RL BZX79C130RL BZX79C150RL				
160 170 180 190 200 220	1N990B 1N991B 1N992B		1N5277B 1N5278B 1N5279B 1N5280B 1N5281B			BZX79C160RL BZX79C180RL BZX79C200RL				
240 270 300 330 360 400							-			

<sup>\*</sup>See Notes on page 5.2-20.

Devices listed in bold, italic are Motorola preferred devices

### Zener Diodes Voltage Regulator Diodes (continued)

Table 14. Axial Leaded for Through-hole Designs - 1, 1.3, 1.5, 3 and 5 Watt

Nominal Zener	1	Vett	Ole Designs -	1.3 Watt		1.5 Watt	3 Watt	5 Watt
Breakdown Voltage	4	ode = y Band		Cathode = Polarity Band		Cathode = Polarity Band	Cathode = Polarity Band	Cathode = Polarity Band
(*Note 1)	(*Note 11)	(*Note 12)	(*Note 13)	(*Note 14)	(*Note 15)	(*Note 16)	(*Note 17)	(*Note 18)
Volts	Glass Case 59-03 (DO-41)	Plastic Surmetic 30 Case 59–03 (DO–41)	Glass Case 59-03 (DO-41)			Sun Cas	Plastic metic 30 te 59-03 (O-41)	Plastic Surmetic 40 Case 17
3.3	1N4728A	MZP4728A	BZX85C3V3RL	<u> </u>		1N5913B		1N5333B
3.6 3.9 4.3 4.7 5.1 5.6 6.0	1N4729A 1N4730A 1N4731A 1N4732A 1N4733A 1N4734A	MZP4729A MZP4730A MZP4731A MZP4732A MZP4733A MZP4734A	BZX85C3V6RL BZX85C3V9RL BZX85C4V3RL BZX85C4V7RL BZX85C5V1RL BZX85C5V6RL	MZPY3.9RL MZPY4.3RL MZPY4.7RL MZPY5.1RL MZPY5.6RL	MZD3.9RL MZD4.3RL MZD4.7RL MZD5.1RL MZD5.6RL	1N5914B 1N5915B 1N5916B 1N5917B 1N5918B 1N5919B	3EZ3.9D5 3EZ4.3D5 3EZ4.7D5 3EZ5.1D5 3EZ5.6D5	1N5334B 1N5335B 1N5336B 1N5337B 1N5338B 1N5339B
6.2	1N4735A	MZP4735A	BZX85C6V2RL	MZPY6.2RL	MZD6.2RL	1N5920B	3EZ6.2D5	1N5340B 1N5341B
6.8	1N4736A	MZP4736A	BZX85C6V8RL	MZPY6.8RL	MZD6.8RL	1N5921B	3EZ6.805	1N5342B
7.5	1N4737A	MZP4737A ·	BZX85C7V5RL	MZPY7.5RL	MZD7.5RL	1N5922B	3EZ7.505	1N5343B
8.2	1N4738A	MZP4738A	BZX85C8V2RL	MZPY8.2RL	MZD8.2RL	1N5923B	3EZ8.2D5	1N5344B
8.7								1N5345B
9.1	1N4739A	MZP4739A	BZX85C9V1RL	MZPY9.1RL	MZD9.1RL	1N5924B	3EZ9.1D5	1N5346B
10	1N4740A	MZP4740A	BZX85C10RL	MZPY10RL	MZD10AL	1N5925B	3EZ1005	1N5347B
11	1N4741A	MZP4741A	BZX85C11RL	MZPY11RL	MZD11RL	1N5926B	3EZ11D5	1N5348B
12	1N4742A	MZP4742A	BZX85C12RL	MZPY12RL	MZD12RL	1N5927B	3EZ12D5	1N5349B
13 14	1N4743A	MZP4743A	BZX85C13RL	MZPY13RL	MZD13RL	1N5928B	3EZ13D5 3EZ14D5	1N5350B 1N5351B
15 16	1N4744A 1N4745A	MZP4744A MZP4745A	BZX85C15RL BZX85C16RL	MZPY15RL	MZD15RL	1N59298	3EZ15D5	1N5352B
17		WIE/ 4/43A	BEAGSCIGHE	MZPY16RL	MZD16RL	1N5930B	3EZ16D5 3EZ17D5	1N5353B
18	1N4746A	MZP4746A	BZX85C18RL	MZPY18RL	MZD18RL	1N5931B	3EZ18D5	1N5354B 1N5355B
19 - 20 22 24 25 27	1N4747A 1N4748A 1N4749A 1N4750A	MZP4747A MZP4748A <b>MZP4749A</b> MZP4750A	BZX85C20RL BZX85C22RL BZX85C24RL BZX85C27RL	MZPY20RL MZPY22RL MZPY24RL MZPY27RL	MZD20RL MZD22RL MZD24RL MZD27RL	1N5932B 1N5933B 1N5934B 1N5935B	3EZ1905 3EZ2005 3EZ2205 3EZ2405 3EZ2705	1N5356B 1N5357B 1N5358B 1N5359B 1N5360B 1N5361B
28 30	1N4751A	MZP4751A	BZX85C30RL	MZPY30RL	MZD30RL	1N5936B	3EZ2805 3EZ3005	1N5362B 1N5363B
33 36	1N4752A	MZP4752A	BZX85C33RL	MZPY33RL	MZD33RL	1N5937B	3EZ33D5	1N5364B
39	1N4753A 1N4754A	MZP4753A MZP4754A	BZX85C36RL BZX85C39RL	MZPY36RL MZPY39RL	MZD36RL MZD39RL	1N59388	3EZ36D5	1N5365B
43	1N4755A	MZP4755A	BZX85C43RL	MZPY43RL	MZD39HL MZD43RL	1N59398 1N5940B	3EZ39D5 3EZ43D5	1N5366B 1N5367B
47	1N4756A	MZP4756A	BZX85C47RL	MZPY47RL	MZD47RL	1N5941B	3EZ47D5	1N5368B
51	1N4757A	MZP4757A	BZX85C51RL	MZPY51RL	MZD51	1N5942B	3EZ51D5	
56 60	1N4758A	MZP4758A	BZX85C56RL	MZPY56RL	MZD56	1N59438	3EZ56D5	1N5369B 1N5370B
60 62	1N4759A	MZP4759A	BZX85C62RL	MZPY62RL	MZD62	1N5944B	2570000	1N5371B
68	1N4760A	MZP4760A	BZX85C68RL	MZPY68AL	1	I	3EZ62D5	1N5372B
*See Notes on nar		MZF4/BUA	DZX85C68HL	MZPY68FIL	MZD68	1N5945B	3EZ68D5	1N5373B

\*See Notes on page 5.2-20.

Devices listed in bold, italic are Motorola preferred devices

### μΑ78xxY chip information

These chips, when properly assembled, display characteristics similar to the µA78xxC. Thermal compression or ultrasonic bonding may be used on the doped aluminum bonding pads. The chips may be mounted with conductive epoxy or a gold-silicon preform.

